

JC03 Rec'd PCT/PTO 11 APR 2009 f CT
10/530780IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Patent Application of:

Applicant: Robert E. Imhof

Serial No.: PCT/GB2003/004365

For: Method and Equipment For
Measuring Vapour Flux From
SurfacesINFORMATION DISCLOSURE STATEMENTHonorable Commissioner for
Patents

) Art Unit: Unknown

) Examiner: Unknown

) Docket No.: BSL-1-PCT

) I hereby certify that this
) correspondence is being deposited with
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) addressed to: Commissioner for
) Patents, Alexandria, V.A. 22313
) on) 8 APRIL 2005
) R. B. SHERER
) RPJ
) 18 APR. 2005

Sir:

Pursuant to 37 CFR §1.56, §1.97 and §1.98 in relation to the subject new application, enclosed is Form PTO-A820 listing references, together with a copy of each of these references.

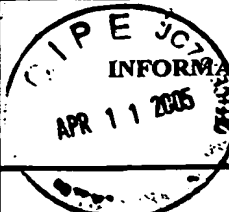
Six references are in English. A translation of Japanese WO 02/054041 will follow.

None of these references anticipate the subject matter claimed in the subject application. However, it is requested that they be made of record as having been considered in the prosecution of the subject application.

Respectfully submitted,

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 INFORMATION DISCLOSURE CITATION <small>(Use several sheets if necessary)</small>				Docket Number (Optional) BSL-1-PCT		Application Number PCT/GB2003/004365		
				Applicant(s) ROBERT M. IMHOF				
				Filing Date 8 OCT. 2003		Group Art Unit UNKNOWN		
U.S. PATENT DOCUMENTS								
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
		2002/0137992	9/28/02	LAHTINEN	600	307		
		6,125,687	10/3/00	MCCLELLAND ET AL	73	19.01		
		3,465,591	9/9/69	BACHEM	73	336.5		
		4,066,068	1/3/78	NILLOON ET AL	128	2R		
		5,343,747	6/9/94	ROSEN	73	335.06		
<i>US PAT. DOCS CONT'D</i>								
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
		6,439,028	8/27/02	IMHOF	73	29.01		
FOREIGN PATENT DOCUMENTS								
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
		WO 02/054041	11/7/02	JAPAN	G01N	1/22		
OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>								
EXAMINER					DATE CONSIDERED			
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP Section 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								